Special Issue

Applications of Deep Learning in Cyber Threat Detection

Message from the Guest Editors

The exponential growth of network intrusions and cyberattacks poses a significant threat to critical infrastructure across various sectors. This growth necessitates the development of advanced artificial intelligence techniques for cyber threat detection where securing current systems and networks against such threats. Potential topics of interest include, but are not limited to, the following:

- Deep learning methods for advanced network intrusion detection;
- Deep learning-based ensemble learning methods for cyber threat detection;
- Explainable Al for explaining black-box deep learning methods in network intrusion detection:
- Efficiency analysis and optimization of deep learning methods for cyber threat detection;
- Deep learning methods for detecting threats to Internet-of-things (IoT) networks;
- Feature selection for enhancing performance of deep learning methods for cyberthreat detection;
- Evaluation frameworks for current deep learning methods for cyber threat detection;
- Reliability of deep learning-based cyber threat detection methods;
- Adversarial attacks on deep neural networks for cyber threat detection.

Guest Editors

Dr. Mustafa Abdallah

Computer and Information Technology Department, Purdue University in Indianapolis, Indianapolis, IN 46222, USA

Dr. Xiao Luo

Department of Management Science & Information Systems, Oklahoma State University, Stillwater, OK 74078, USA

Deadline for manuscript submissions

15 October 2025



Electronics

an Open Access Journal by MDPI

Impact Factor 2.6 CiteScore 6.1



mdpi.com/si/217001

Electronics
Editorial Office
MDPI, Grosspeteranlage 5
4052 Basel, Switzerland
Tel: +41 61 683 77 34
electronics@mdpi.com

mdpi.com/journal/electronics





Electronics

an Open Access Journal by MDPI

Impact Factor 2.6 CiteScore 6.1



About the Journal

Message from the Editor-in-Chief

Electronics is a multidisciplinary journal designed to appeal to a diverse audience of research scientists, practitioners, and developers in academia and industry. The journal is devoted to fast publication of latest technological breakthroughs, cutting-edge developments, and timely reviews of current and emerging technologies related to the broad field of electronics. Experimental and theoretical results are published as regular peer-reviewed articles or as articles within Special Issues guestedited by leading experts in selected topics of interest.

Editor-in-Chief

Prof. Dr. Flavio Canavero

Department of Electronics and Telecommunications, Politecnico di Torino, 10129 Torino, Italy

Author Benefits

High Visibility:

indexed within Scopus, SCIE (Web of Science), CAPlus / SciFinder, Inspec, Ei Compendex and other databases.

Journal Rank:

JCR - Q2 (Engineering, Electrical and Electronic) / CiteScore - Q1 (Electrical and Electronic Engineering)

Rapid Publication:

manuscripts are peer-reviewed and a first decision is provided to authors approximately 16.8 days after submission; acceptance to publication is undertaken in 2.4 days (median values for papers published in this journal in the first half of 2025).

